.U.S. Department of Commerce, Patent an	Docket No.	Serial No.	
(PTO Form 1449 modified)	WEAT/0379	10/696,766	
INFORMATION DISCLOSURE STATEM	Applicant Trevor McDougall	Confirmation No.: 6665	
(Use several sheets if necessary)	7	Filing Date	Group
Examiner	\$ JUL 2 8 2004 \(\frac{\frac{1}{2}}{2}\)	October 29, 2003	2877
	E GEST	Sheet 1 of 2	

U	.S. Pat	ent Do	cume	nts	S. S. Fill	Million of the second			
*Examiner Initial		Document Number			Issue Date	Applicant(s) Name	Class	Subclass	Filing Date if Appropriate
P		Α	1	6,555,807 B2	04/29/2003	Clayton et al.	250	227.16	
			2	6,519,388 B1	02/11/2003	Fernald et al.	385	37	
			3	6,452,667 B1	09/17/2002	Fernald et al.	356	73.1	
			4	6,422,084 B1	07/23/2002	Fernald et al.	73	705	
1			5	6,404,961 B1	06/11/2002	Bonja et al.	385	109	. 4
			6	6,363,089 B1	10/19/2000	Fernald et al.	372	20	•
			7	6,298,184 B1	10/02/2001	Putnam et al.	385	37	
			8	5,483,607	01/09/1996	O'Keefe	385	11	
			9	4,767,219	08/30/1988	Bibby	374	123	·. ·
			10	Ser. No. 10/422,396		Dowd et al.			04/24/2003
T	W		11	Ser. No. 10/397,754		MacDougall			03/26/2003

Initial	Document Number	Date	Country	Class	Subclass	Translation	
						YES	NO

Examiner Date Considered 12/07/05

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line. through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

, Ù'S. Department of Commerce, Patent and Trademark Office			Docket No.	Serial No.	
(PTO Form 1449 modified) INFORMATION DISCLOSURE STATEMENT BY APPLICANT			WEAT/0379	10/696,766 Confirmation No.: 6665	
			Applicant Trevor McDougall		
(Use several sheets if necessary)			Filing Date	Group	
Examiner			October 29, 2003	2877	
			Sheet 2 of 2		
OTHER AF	RT				
*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.			
	C 1	SAKAIRI ET AL., "A System for Measuring To	emperature and Strain	Separately by BOTD	

OTHER A	रा	• • •
*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
P	C 1	SAKAIRI ET AL., "A System for Measuring Temperature and Strain Separately by BOTDR and OTDR", <i>Advanced Sensor Systems and Applications</i> , Proceedings of SPIE Vol. 4920, pp. 274-284 (2002) U.S.A.
R	C 2	TANAKA ET AL., "Polarization Dependence of Depolarized Guided Acoustic-Wave Brillouin Scattering Detected After an Analyzer", <i>Journal of Optical Communications</i> , pp. 82-85 (2000) U.S.A.
P	C 3	TANAKA ET AL., "Polarization Dependence of Amplitude Modulation by Guided Acoustic-Wave Brillouin Scattering", Department of Electrical and Electronic Engineering, Shizuoka University, SPIE Vol. 3746, pp. 116-119 (1999) Japan
N	C 4	BAO, "Tensile and Compressive Strain Measurement in the Lab and Field with the Distributed Brillouin Scattering Sensor", <i>Journal of Lightwave Technology</i> , Vol. 19, No. 11, pp. 1698-1704 (Nov. 2001) U.S.A.

Examiner Date Considered

12/07/05

٠.٠٠